

TOSHIBA Bipolar Digital Integrated Circuit Silicon Monolithic

ULN2003APG, ULN2003AFWG, ULN2004APG, ULN2004AFWG (Manufactured by Toshiba Malaysia)

7ch Darlington Sink Driver

The ULN2003APG/AFWG Series are high-voltage, high-current darlington drivers comprised of seven NPN darlington pairs. All units feature integral clamp diodes for switching inductive loads.

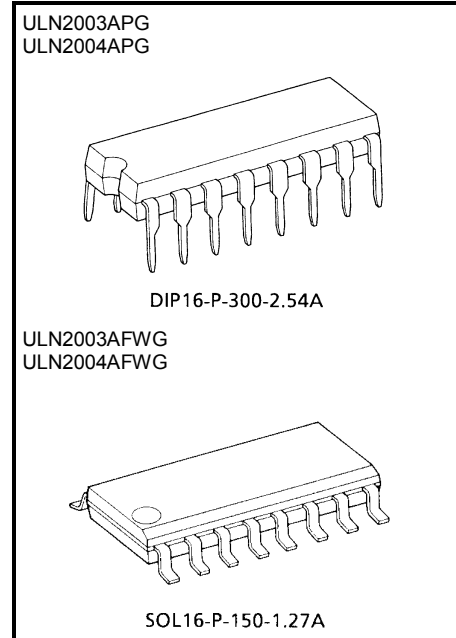
Applications include relay, hammer, lamp and display (LED) drivers.

The suffix (G) appended to the part number represents a Lead (Pb)-Free product.

Features

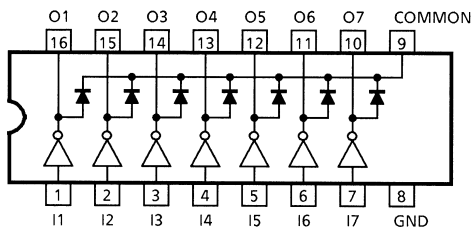
- Output current (single output): 500 mA max
- High sustaining voltage output: 50 V min
- Output clamp diodes
- Inputs compatible with various types of logic
- Package Type-APG: DIP-16pin
- Package Type-AFWG: SOL-16pin

Type	Input Base Resistor	Designation
ULN2003APG/AFWG	2.7 k Ω	TTL, 5 V CMOS
ULN2004APG/AFWG	10.5 k Ω	6~15 V PMOS, CMOS



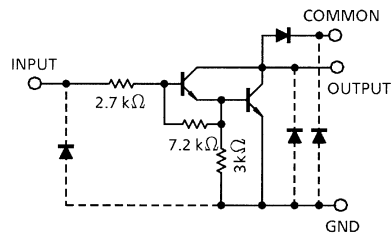
Weight
 DIP16-P-300-2.54A : 1.11 g (typ.)
 SOL16-P-150-1.27A: 0.15 g (typ.)

Pin Connection (top view)

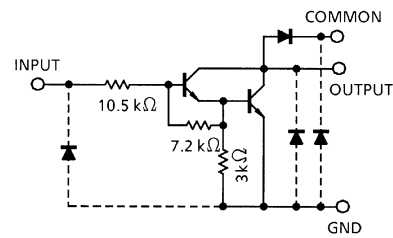


Schematics (each driver)

ULN2003APG/AFWG



ULN2004APG/AFWG



Note: The input and output parasitic diodes cannot be used as clamp diodes.

Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Output sustaining voltage	$V_{CE(SUS)}$	-0.5~50	V
Output current	I_{OUT}	500	mA/ch
Input voltage	V_{IN}	-0.5~30	V
Clamp diode reverse voltage	V_R	50	V
Clamp diode forward current	I_F	500	mA
Power dissipation	APG	1.47	W
	AFWG	1.25 (Note)	
Operating temperature	T_{opr}	-40~85	°C
Storage temperature	T_{stg}	-55~150	°C

Note: On PCB (Test Board: JEDEC 2s2p)

Recommended Operating Conditions (Ta = -40 to 85°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit	
Output sustaining voltage		$V_{CE(SUS)}$		0	—	50	V	
Output current	APG	I_{OUT}	$T_{pw} = 25\text{ ms}$ 7 Circuits $T_a = 85^\circ\text{C}$ $T_j = 120^\circ\text{C}$	Duty = 10%	0	—	350	mA/ch
	AFWG			Duty = 50%	0	—	100	
				Duty = 10%	0	—	300	
				Duty = 50%	0	—	90	
Input voltage		V_{IN}		0	—	24	V	
Input voltage (output on)	ULN2003A	$V_{IN(ON)}$	$I_{OUT} = 400\text{ mA}$ $h_{FE} = 800$	2.8	—	24	V	
	ULN2004A			6.2	—	24		
Input voltage (output off)	ULN2003A	$V_{IN(OFF)}$		0	—	0.7	V	
	ULN2004A			0	—	1.0		
Clamp diode reverse voltage		V_R		—	—	50	V	
Clamp diode forward current		I_F		—	—	350	mA	
Power dissipation	APG	P_D	$T_a = 85^\circ\text{C}$	—	—	0.76	W	
	AFWG		$T_a = 85^\circ\text{C}$ (Note)	—	—	0.65		

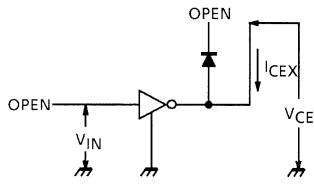
Note: On PCB (Test Board: JEDEC 2s2p)

Electrical Characteristics (Ta = 25°C unless otherwise noted)

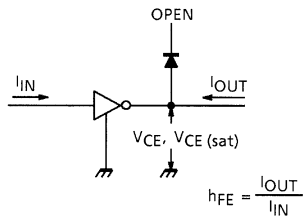
Characteristic	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit		
Output leakage current	I_{CEX}	1	$V_{CE} = 50\text{ V}, T_a = 25^\circ\text{C}$	—	—	50	μA		
			$V_{CE} = 50\text{ V}, T_a = 85^\circ\text{C}$	—	—	100			
Collector-emitter saturation voltage	$V_{CE(sat)}$	2	$I_{OUT} = 350\text{ mA}, I_{IN} = 500\text{ }\mu\text{A}$	—	1.3	1.6	V		
			$I_{OUT} = 200\text{ mA}, I_{IN} = 350\text{ }\mu\text{A}$	—	1.1	1.3			
			$I_{OUT} = 100\text{ mA}, I_{IN} = 250\text{ }\mu\text{A}$	—	0.9	1.1			
DC Current transfer ratio	h_{FE}	2	$V_{CE} = 2\text{ V}, I_{OUT} = 350\text{ mA}$	1000	—	—			
Input current (output on)	ULN2003A	$I_{IN(ON)}$	3	$V_{IN} = 2.4\text{ V}, I_{OUT} = 350\text{ mA}$	—	0.4	0.7	mA	
	ULN2004A								$V_{IN} = 9.5\text{ V}, I_{OUT} = 350\text{ mA}$
Input current (output off)	$I_{IN(OFF)}$	4	$I_{OUT} = 500\text{ }\mu\text{A}, T_a = 85^\circ\text{C}$	50	65	—	μA		
Input voltage (output on)	ULN2003A	$V_{IN(ON)}$	5	$V_{CE} = 2\text{ V}$ $h_{FE} = 800$	—	—	$I_{OUT} = 350\text{ mA}$	2.6	
							$I_{OUT} = 200\text{ mA}$		2.0
	ULN2004A						$I_{OUT} = 350\text{ mA}$		4.7
							$I_{OUT} = 200\text{ mA}$		4.4
Clamp diode reverse current	I_R	6	$V_R = 50\text{ V}, T_a = 25^\circ\text{C}$	—	—	50	μA		
			$V_R = 50\text{ V}, T_a = 85^\circ\text{C}$	—	—	100			
Clamp diode forward voltage	V_F	7	$I_F = 350\text{ mA}$	—	—	2.0	V		
Input capacitance	C_{IN}	—		—	15	—	pF		
Turn-on delay	t_{ON}	8	$V_{OUT} = 50\text{ V}, R_L = 125\text{ }\Omega$ $C_L = 15\text{ pF}$	—	0.1	—	μs		
Turn-off delay	t_{OFF}	8	$V_{OUT} = 50\text{ V}, R_L = 125\text{ }\Omega$ $C_L = 15\text{ pF}$	—	0.2	—			

Test Circuit

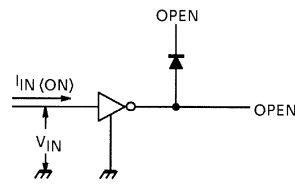
1. I_{CEX}



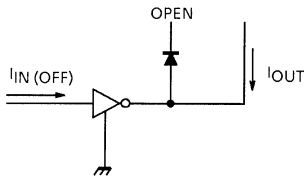
2. $V_{CE} (sat), h_{FE}$



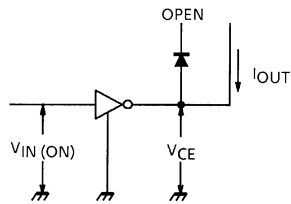
3. $I_{IN} (ON)$



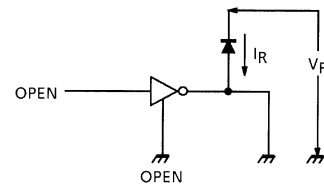
4. $I_{IN} (OFF)$



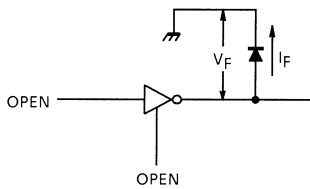
5. $V_{IN} (ON)$



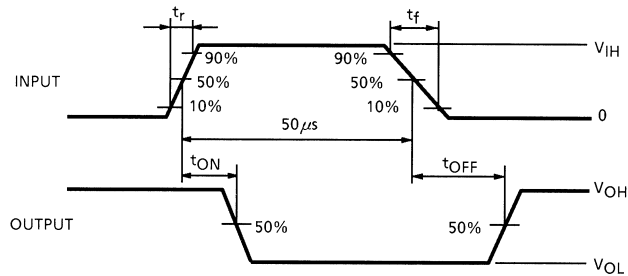
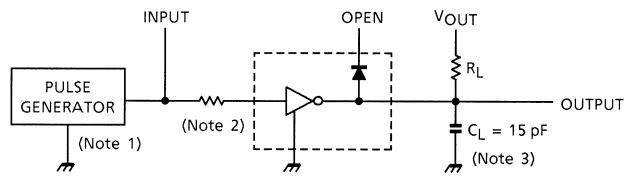
6. I_R



7. V_F



8. t_{ON} , t_{OFF}



Note 1: Pulse width 50 μ s, duty cycle 10%
Output impedance 50 Ω , $t_r \leq 5$ ns, $t_f \leq 10$ ns

Note 2: See below

Input Condition

Type Number	R1	V_{IH}
ULN2003A	0	3 V
ULN2004A	0	8 V

Note 3: C_L includes probe and jig capacitance.

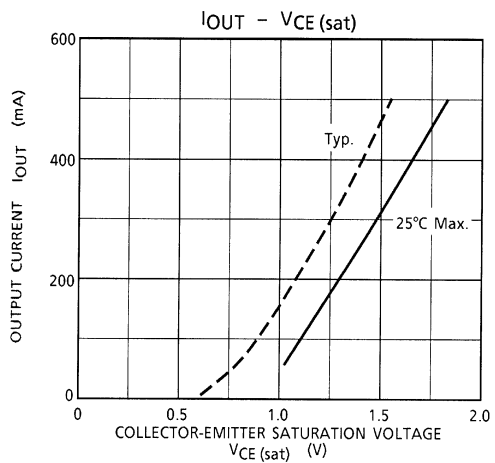
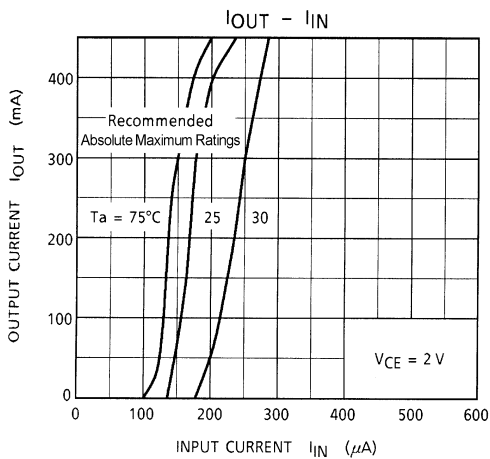
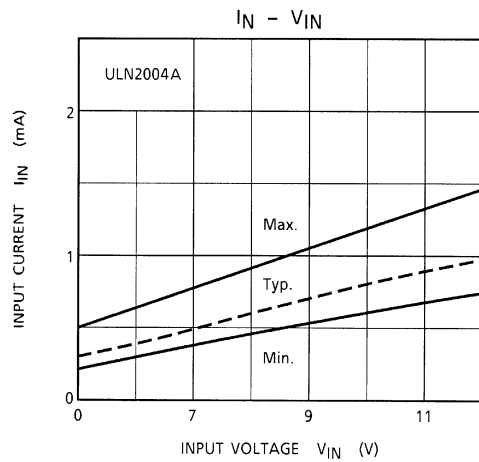
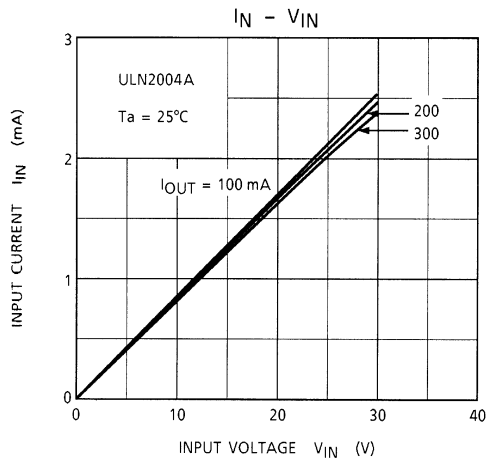
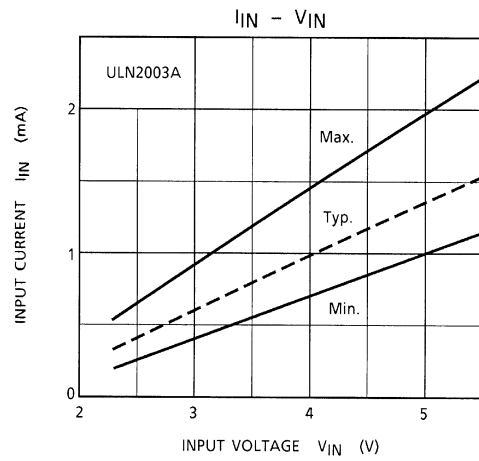
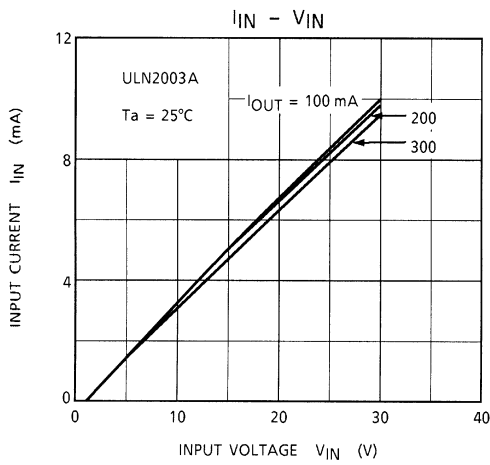
Precautions for Using

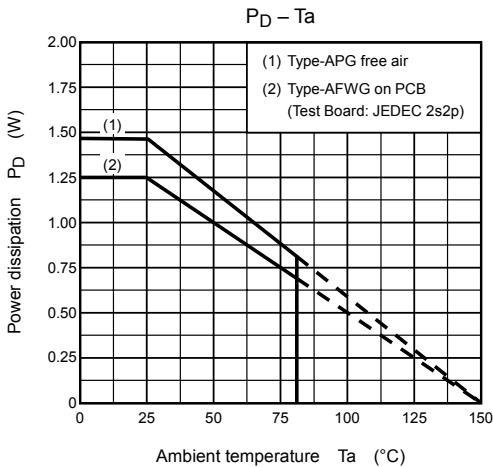
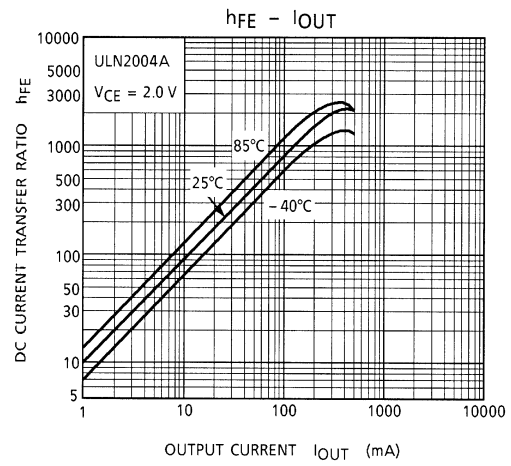
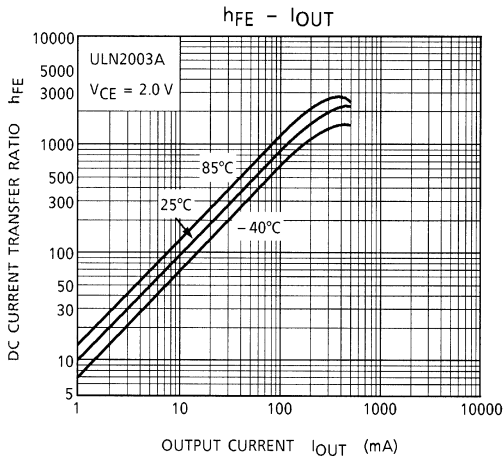
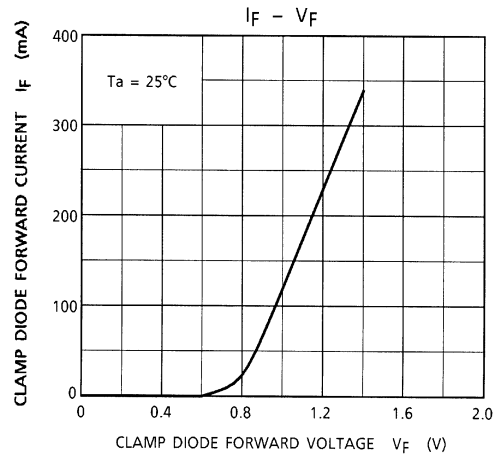
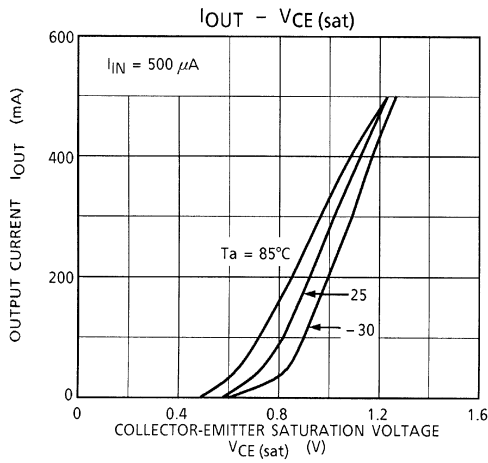
This IC does not include built-in protection circuits for excess current or overvoltage.

If this IC is subjected to excess current or overvoltage, it may be destroyed.

Hence, the utmost care must be taken when systems which incorporate this IC are designed.

Utmost care is necessary in the design of the output line, COMMON and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

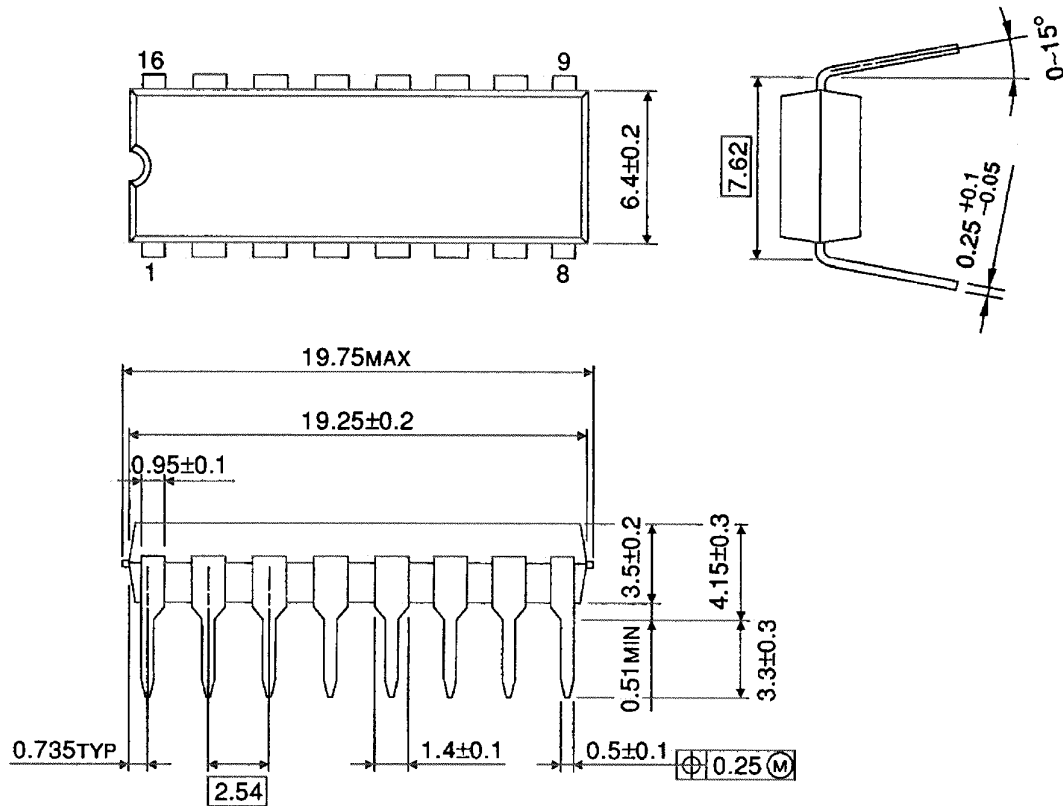




Package Dimensions

DIP16-P-300-2.54A

Unit : mm

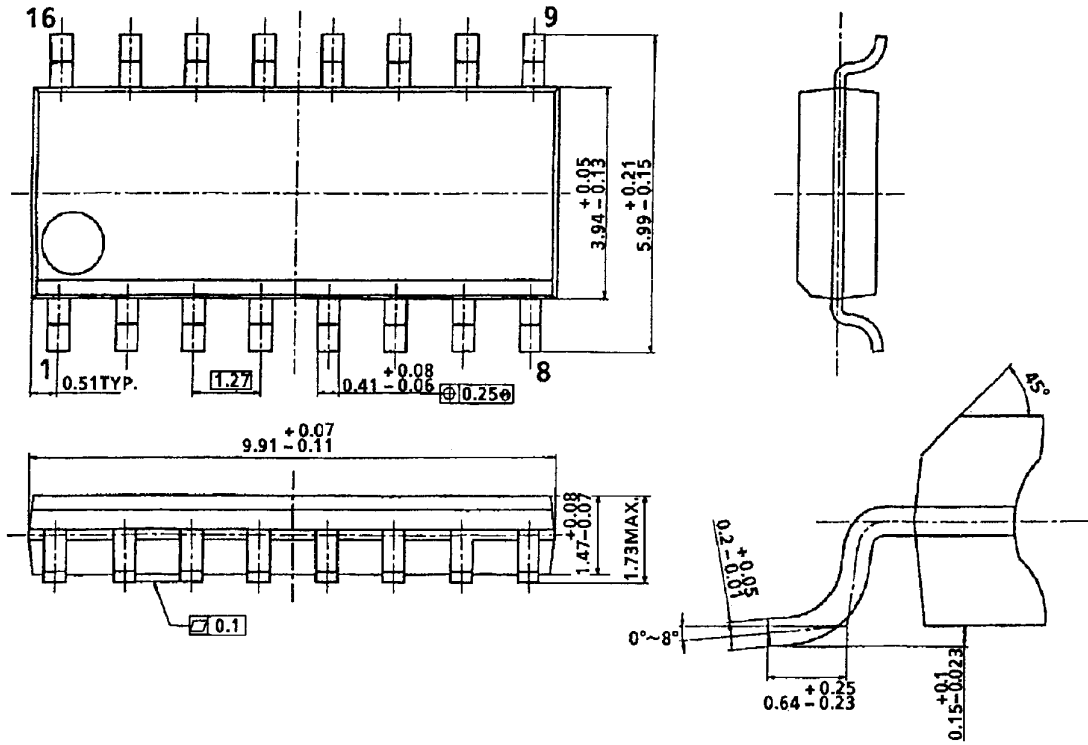


Weight: 1.11 g (typ.)

Package Dimensions

SOL16-P-150-1.27A

Unit : mm



Weight: 0.15 g (typ.)

Notes on Contents

1. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

2. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations

Notes on Handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.
Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly.
Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.
If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

Points to Remember on Handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (T_j) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into consideration the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

About solderability, following conditions were confirmed

- Solderability
 - (1) Use of Sn-37Pb solder Bath
 - solder bath temperature = 230°C
 - dipping time = 5 seconds
 - the number of times = once
 - use of R-type flux
 - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
 - solder bath temperature = 245°C
 - dipping time = 5 seconds
 - the number of times = once
 - use of R-type flux

RESTRICTIONS ON PRODUCT USE

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